N-Channel Enhancement-Mode Vertical DMOS FET

Features
- Free from Secondary Breakdown
- Low Power Drive Requirement
- Ease of Paralleling
- Low $C_{ISS}$ and Fast Switching Speeds
- Excellent Thermal Stability
- Integral Source-Drain Diode
- High Input Impedance and High Gain

Applications
- Logic-Level Interfaces (Ideal for TTL and CMOS)
- Solid-State Relays
- Battery-Operated Systems
- Photovoltaic Drives
- Analog Switches
- General Purpose Line Drivers
- Telecommunication Switches

General Description
The TN2130 low-threshold, Enhancement-mode (normally-off) transistor uses a vertical DMOS structure and a well-proven silicon-gate manufacturing process. This combination produces a device with the power handling capabilities of bipolar transistors and the high input impedance and positive temperature coefficient inherent in MOS devices. Characteristic of all MOS structures, this device is free from thermal runaway and thermally induced secondary breakdown.

Microchip’s vertical DMOS FETs are ideally suited to a wide range of switching and amplifying applications where very low threshold voltage, high breakdown voltage, high input impedance, low input capacitance, and fast switching speeds are desired.

Package Type

See Table 3-1 for pin information.
1.0 ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings†
Drain-to-Source Voltage ...................................................................................................................................... \( BV_{DSS} \)
Drain-to-Gate Voltage ......................................................................................................................................... \( BV_{DGS} \)
Gate-to-Source Voltage ......................................................................................................................................... ±20V
Operating Ambient Temperature, \( T_A \) ................................................................................................... –55°C to +150°C
Storage Temperature, \( T_S \) ..................................................................................................................... –55°C to +150°C

† Notice: Stresses above those listed under “Absolute Maximum Ratings” may cause permanent damage to the
device. This is a stress rating only, and functional operation of the device at those or any other conditions above those
indicated in the operational sections of this specification is not intended. Exposure to maximum rating conditions for
extended periods may affect device reliability.

DC ELECTRICAL CHARACTERISTICS – COMMERCIAL

Electrical Specifications: \( T_A = T_J = 25^\circ C \) unless otherwise specified. All DC parameters are 100% tested at 25°C
unless otherwise stated. (Pulse test: 300 \( \mu \)s pulse, 2% duty cycle)

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Sym.</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
<th>Unit</th>
<th>Conditions</th>
</tr>
</thead>
<tbody>
<tr>
<td>Drain-to-Source Breakdown Voltage</td>
<td>( BV_{DSS} )</td>
<td>300</td>
<td>—</td>
<td>—</td>
<td>V</td>
<td>( V_{GS} = 0V, I_D = 1 ) mA</td>
</tr>
<tr>
<td>Gate Threshold Voltage</td>
<td>( V_{GS(th)} )</td>
<td>0.8</td>
<td>2.4</td>
<td>—</td>
<td>V</td>
<td>( V_{GS} = V_{DS}, I_D = 1 ) mA</td>
</tr>
<tr>
<td>Change in ( V_{GS(th)} ) with Temperature</td>
<td>( \Delta V_{GS(th)} )</td>
<td>—</td>
<td>—</td>
<td>–5.5</td>
<td>mV/°C</td>
<td>( V_{GS} = V_{DS}, I_D = 1 ) mA (Note 1)</td>
</tr>
<tr>
<td>Gate Body Leakage Current</td>
<td>( I_{GSS} )</td>
<td>—</td>
<td>100</td>
<td>—</td>
<td>nA</td>
<td>( V_{GS} = \pm 20V, V_{DS} = 0V</td>
</tr>
<tr>
<td>Zero-Gate Voltage Drain Current</td>
<td>( I_{DSS} )</td>
<td>—</td>
<td>—</td>
<td>10</td>
<td>μA</td>
<td>( V_{GS} = 0V, V_{DS} = \text{Maximum rating}</td>
</tr>
<tr>
<td>On-State Drain Current</td>
<td>( I_{D(ON)} )</td>
<td>250</td>
<td>—</td>
<td>—</td>
<td>mA</td>
<td>( V_{GS} = 10V, V_{DS} = 25V</td>
</tr>
<tr>
<td>Static Drain-to-Source On-State Resistance</td>
<td>( R_{DS(ON)} )</td>
<td>—</td>
<td>25</td>
<td>—</td>
<td>Ω</td>
<td>( V_{GS} = 4.5V, I_D = 120 ) mA</td>
</tr>
<tr>
<td>Change in ( R_{DS(ON)} ) with Temperature</td>
<td>( \Delta R_{DS(ON)} )</td>
<td>—</td>
<td>1.1</td>
<td>—</td>
<td>%/°C</td>
<td>( V_{GS} = 4.5V, I_D = 120 ) mA (Note 1)</td>
</tr>
</tbody>
</table>

Note 1: Specification is obtained by characterization and is not 100% tested.

DC ELECTRICAL CHARACTERISTICS – AUTOMOTIVE

Electrical Specifications: \( T_A = T_J = (–55^\circ C, 25^\circ C, \) and \( 150^\circ C) \) unless otherwise specified. All DC parameters are 100% tested at all three temperatures unless otherwise stated. (Pulse test: 300 \( \mu \)s pulse, 2% duty cycle.)

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Sym.</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
<th>Unit</th>
<th>Conditions</th>
</tr>
</thead>
<tbody>
<tr>
<td>Drain-to-Source Breakdown Voltage</td>
<td>( BV_{DSS} )</td>
<td>300</td>
<td>—</td>
<td>—</td>
<td>V</td>
<td>( V_{GS} = 0V, I_D = 1 ) mA</td>
</tr>
<tr>
<td>Gate Threshold Voltage</td>
<td>( V_{GS(th)} )</td>
<td>0.8</td>
<td>2.4</td>
<td>—</td>
<td>V</td>
<td>( V_{GS} = V_{DS}, I_D = 1 ) mA</td>
</tr>
<tr>
<td>Change in ( V_{GS(th)} ) with Temperature</td>
<td>( \Delta V_{GS(th)} )</td>
<td>—</td>
<td>—</td>
<td>–3.6</td>
<td>mV/°C</td>
<td>( V_{GS} = V_{DS}, I_D = 1 ) mA, ( T_A = 150^\circ C ) (Note 1)</td>
</tr>
<tr>
<td>Gate Body Leakage Current</td>
<td>( I_{GSS} )</td>
<td>—</td>
<td>100</td>
<td>—</td>
<td>nA</td>
<td>( V_{GS} = \pm 20V, V_{DS} = 0V</td>
</tr>
<tr>
<td>Static Drain-to-Source On-State Resistance</td>
<td>( R_{DS(ON)} )</td>
<td>—</td>
<td>25</td>
<td>—</td>
<td>Ω</td>
<td>( V_{GS} = 4.5V, I_D = 120 ) mA</td>
</tr>
</tbody>
</table>

Note 1: Specification is obtained by characterization and is not 100% tested.
### DC ELECTRICAL CHARACTERISTICS – AUTOMOTIVE (CONTINUED)

**Electrical Specifications:** $T_A = T_J = (-55^\circ C, 25^\circ C, \text{and} 150^\circ C)$ unless otherwise specified. All DC parameters are 100% tested at all three temperatures unless otherwise stated. (Pulse test: 300 $\mu$s pulse, 2% duty cycle.)

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Sym.</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
<th>Unit</th>
<th>Conditions</th>
</tr>
</thead>
<tbody>
<tr>
<td>Zero-Gate Voltage Drain Current</td>
<td>$I_{DSS}$</td>
<td>—</td>
<td>—</td>
<td>10</td>
<td>$\mu$A</td>
<td>$V_{GS} = 0V, V_{DS} = \text{Maximum rating}$</td>
</tr>
<tr>
<td></td>
<td></td>
<td>—</td>
<td>—</td>
<td>100</td>
<td>$\mu$A</td>
<td>$V_{GS} = 0V, V_{DS} = \text{Maximum rating, } T_A = 150^\circ C$</td>
</tr>
<tr>
<td>On-State Drain Current</td>
<td>$I_{D(ON)}$</td>
<td>250</td>
<td>—</td>
<td>—</td>
<td>mA</td>
<td>$V_{GS} = 10V, V_{DS} = 25V$</td>
</tr>
<tr>
<td>Static Drain-to-Source On-State Resistance</td>
<td>$R_{DS(ON)}$</td>
<td>—</td>
<td>—</td>
<td>25</td>
<td>$\Omega$</td>
<td>$V_{GS} = 4.5V, I_D = 120 \text{ mA}$</td>
</tr>
<tr>
<td></td>
<td></td>
<td>—</td>
<td>—</td>
<td>66</td>
<td>$\Omega$</td>
<td>$V_{GS} = 4.5V, I_D = 120 \text{ mA, } T_A = 150^\circ C$</td>
</tr>
<tr>
<td>Change in $R_{DS(ON)}$ with Temperature</td>
<td>$\Delta R_{DS(ON)}$</td>
<td>—</td>
<td>1.1</td>
<td>—</td>
<td>%/$^\circ C$</td>
<td>$V_{GS} = 4.5V, I_D = 120 \text{ mA}$ (Note 1)</td>
</tr>
</tbody>
</table>

**Note 1:** Specification is obtained by characterization and is not 100% tested.

### AC ELECTRICAL CHARACTERISTICS – COMMERCIAL

**Electrical Specifications:** $T_A = T_J = 25^\circ C$ unless otherwise specified. Specification is obtained by characterization and is not 100% tested.

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Sym.</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
<th>Unit</th>
<th>Conditions</th>
</tr>
</thead>
<tbody>
<tr>
<td>Forward Transconductance</td>
<td>$G_{FS}$</td>
<td>—</td>
<td>250</td>
<td>—</td>
<td>mmho</td>
<td>$V_{DS} = 25V, I_D = 100 \text{ mA}$</td>
</tr>
<tr>
<td>Input Capacitance</td>
<td>$C_{ISS}$</td>
<td>—</td>
<td>—</td>
<td>50</td>
<td>$pF$</td>
<td>$V_{GS} = 0V, V_{DS} = 25V, f = 1 \text{ MHz}$</td>
</tr>
<tr>
<td>Common Source Output Capacitance</td>
<td>$C_{OSS}$</td>
<td>—</td>
<td>—</td>
<td>15</td>
<td>$pF$</td>
<td>$V_{GS} = 0V, V_{DS} = 25V, f = 1 \text{ MHz}$</td>
</tr>
<tr>
<td>Reverse Transfer Capacitance</td>
<td>$C_{RSS}$</td>
<td>—</td>
<td>—</td>
<td>5</td>
<td>$pF$</td>
<td>$V_{GS} = 0V, V_{DS} = 25V, f = 1 \text{ MHz}$</td>
</tr>
<tr>
<td>Turn-On Delay Time</td>
<td>$t_{d(ON)}$</td>
<td>—</td>
<td>—</td>
<td>10</td>
<td>$ns$</td>
<td>$V_{DD} = 25V, I_D = 120 \text{ mA, } R_{GEN} = 25\Omega$</td>
</tr>
<tr>
<td>Rise Time</td>
<td>$t_r$</td>
<td>—</td>
<td>—</td>
<td>7</td>
<td>$ns$</td>
<td>$V_{DD} = 25V, I_D = 120 \text{ mA, } R_{GEN} = 25\Omega$</td>
</tr>
<tr>
<td>Turn-Off Delay Time</td>
<td>$t_{d(OFF)}$</td>
<td>—</td>
<td>—</td>
<td>12</td>
<td>$ns$</td>
<td>$V_{DD} = 25V, I_D = 120 \text{ mA, } R_{GEN} = 25\Omega$</td>
</tr>
<tr>
<td>Fall Time</td>
<td>$t_f$</td>
<td>—</td>
<td>—</td>
<td>15</td>
<td>$ns$</td>
<td>$V_{DD} = 25V, I_D = 120 \text{ mA, } R_{GEN} = 25\Omega$</td>
</tr>
</tbody>
</table>

**DIODE PARAMETER**

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Sym.</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
<th>Unit</th>
<th>Conditions</th>
</tr>
</thead>
<tbody>
<tr>
<td>Diode Forward Voltage Drop</td>
<td>$V_{SD}$</td>
<td>—</td>
<td>—</td>
<td>1.8</td>
<td>$V$</td>
<td>$V_{GS} = 0V, I_{SD} = 120 \text{ mA}$ (Note 1)</td>
</tr>
<tr>
<td>Reverse Recovery Time</td>
<td>$t_{tr}$</td>
<td>—</td>
<td>400</td>
<td>—</td>
<td>$ns$</td>
<td>$V_{GS} = 0V, I_{SD} = 120 \text{ mA}$</td>
</tr>
</tbody>
</table>

**Note 1:** All DC parameters are 100% tested at $25^\circ C$ unless otherwise stated. (Pulse test: 300 $\mu$s pulse, 2% duty cycle)

### AC ELECTRICAL CHARACTERISTICS – AUTOMOTIVE

**Electrical Specifications:** $T_A = 25^\circ C$ unless otherwise specified. All AC parameters are sample tested.

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Sym.</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
<th>Unit</th>
<th>Conditions</th>
</tr>
</thead>
<tbody>
<tr>
<td>Forward Transconductance</td>
<td>$G_{FS}$</td>
<td>—</td>
<td>205</td>
<td>—</td>
<td>mmho</td>
<td>$V_{DS} = 25V, I_D = 100 \text{ mA}$</td>
</tr>
<tr>
<td>Input Capacitance</td>
<td>$C_{ISS}$</td>
<td>—</td>
<td>29</td>
<td>—</td>
<td>$pF$</td>
<td>$V_{GS} = 0V, V_{DS} = 25V, f = 1 \text{ MHz}$</td>
</tr>
<tr>
<td>Common Source Output Capacitance</td>
<td>$C_{OSS}$</td>
<td>—</td>
<td>6</td>
<td>—</td>
<td>$pF$</td>
<td>$V_{GS} = 0V, V_{DS} = 25V, f = 1 \text{ MHz}$</td>
</tr>
<tr>
<td>Reverse Transfer Capacitance</td>
<td>$C_{RSS}$</td>
<td>—</td>
<td>1.2</td>
<td>—</td>
<td>$pF$</td>
<td>$V_{GS} = 0V, V_{DS} = 25V, f = 1 \text{ MHz}$</td>
</tr>
</tbody>
</table>

**Note 1:** 100% Production Tested at $T_A = T_J = (-55^\circ C, 25^\circ C, \text{and} 150^\circ C)$. 
**AC ELECTRICAL CHARACTERISTICS – AUTOMOTIVE (CONTINUED)**

Electrical Specifications: T<sub>А</sub> = 25°C unless otherwise specified. All AC parameters are sample tested.

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Sym.</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
<th>Unit</th>
<th>Conditions</th>
</tr>
</thead>
<tbody>
<tr>
<td>Turn-On Delay Time</td>
<td>t&lt;sub&gt;d(ON)&lt;/sub&gt;</td>
<td>—</td>
<td>6.8</td>
<td>—</td>
<td>ns</td>
<td>V&lt;sub&gt;DD&lt;/sub&gt; = 25V, I&lt;sub&gt;D&lt;/sub&gt; = 120 mA, R&lt;sub&gt;GEN&lt;/sub&gt; = 25Ω</td>
</tr>
<tr>
<td>Rise Time</td>
<td>t&lt;sub&gt;r&lt;/sub&gt;</td>
<td>—</td>
<td>3</td>
<td>—</td>
<td>ns</td>
<td></td>
</tr>
<tr>
<td>Turn-Off Delay Time</td>
<td>t&lt;sub&gt;d(OFF)&lt;/sub&gt;</td>
<td>—</td>
<td>12</td>
<td>—</td>
<td>ns</td>
<td></td>
</tr>
<tr>
<td>Fall Time</td>
<td>t&lt;sub&gt;f&lt;/sub&gt;</td>
<td>—</td>
<td>7</td>
<td>—</td>
<td>ns</td>
<td></td>
</tr>
</tbody>
</table>

**DIODE PARAMETER**

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Sym.</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
<th>Unit</th>
<th>Conditions</th>
</tr>
</thead>
<tbody>
<tr>
<td>Diode Forward Voltage Drop</td>
<td>V&lt;sub&gt;SD&lt;/sub&gt;</td>
<td>—</td>
<td>—</td>
<td>1.8</td>
<td>V</td>
<td>V&lt;sub&gt;GS&lt;/sub&gt; = 0V, I&lt;sub&gt;SD&lt;/sub&gt; = 120 mA (Note 1)</td>
</tr>
<tr>
<td>Reverse Recovery Time</td>
<td>t&lt;sub&gt;rr&lt;/sub&gt;</td>
<td>—</td>
<td>450</td>
<td>—</td>
<td>ns</td>
<td>V&lt;sub&gt;GS&lt;/sub&gt; = 0V, I&lt;sub&gt;SD&lt;/sub&gt; = 120 mA</td>
</tr>
</tbody>
</table>

**TEMPERATURE SPECIFICATIONS**

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Sym.</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
<th>Unit</th>
<th>Conditions</th>
</tr>
</thead>
<tbody>
<tr>
<td>TEMPERATURE RANGE</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Operating Ambient Temperature</td>
<td>T&lt;sub&gt;A&lt;/sub&gt;</td>
<td>−55</td>
<td>—</td>
<td>+150</td>
<td>°C</td>
<td></td>
</tr>
<tr>
<td>Storage Temperature</td>
<td>T&lt;sub&gt;S&lt;/sub&gt;</td>
<td>−55</td>
<td>—</td>
<td>+150</td>
<td>°C</td>
<td></td>
</tr>
</tbody>
</table>

**PACKAGE THERMAL RESISTANCE**

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Sym.</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
<th>Unit</th>
<th>Conditions</th>
</tr>
</thead>
<tbody>
<tr>
<td>3-lead SOT-23</td>
<td>θ&lt;sub&gt;JA&lt;/sub&gt;</td>
<td>—</td>
<td>203</td>
<td>—</td>
<td>°C/W</td>
<td></td>
</tr>
</tbody>
</table>

**THERMAL CHARACTERISTICS**

<table>
<thead>
<tr>
<th>Package</th>
<th>I&lt;sub&gt;D&lt;/sub&gt; (Note 1) (Continuous) (mA)</th>
<th>I&lt;sub&gt;D&lt;/sub&gt; (Pulsed) (mA)</th>
<th>Power Dissipation at T&lt;sub&gt;A&lt;/sub&gt; = 25°C (W)</th>
<th>I&lt;sub&gt;DR&lt;/sub&gt; (Note 1) (mA)</th>
<th>I&lt;sub&gt;DRM&lt;/sub&gt; (mA)</th>
</tr>
</thead>
<tbody>
<tr>
<td>3-lead SOT-23</td>
<td>85</td>
<td>200</td>
<td>0.36</td>
<td>85</td>
<td>200</td>
</tr>
</tbody>
</table>

**Note 1:** I<sub>D</sub> (continuous) is limited by maximum rated T<sub>J</sub>.
2.0 TYPICAL PERFORMANCE CURVES

Note: The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs or tables, the data presented may be outside the specified operating range (e.g. outside specified power supply range) and therefore outside the warranted range.

![Figure 2-1: Output Characteristics](image1)

**FIGURE 2-1:** Output Characteristics.

![Figure 2-2: Transconductance vs. Drain Current](image2)

**FIGURE 2-2:** Transconductance vs. Drain Current.

![Figure 2-3: Maximum Rated Safe Operating Area](image3)

**FIGURE 2-3:** Maximum Rated Safe Operating Area.

![Figure 2-4: Saturation Characteristics](image4)

**FIGURE 2-4:** Saturation Characteristics.

![Figure 2-5: Power Dissipation vs. Case Temperature](image5)

**FIGURE 2-5:** Power Dissipation vs. Case Temperature.

![Figure 2-6: Thermal Response Characteristics](image6)

**FIGURE 2-6:** Thermal Response Characteristics.
FIGURE 2-7: \( BV_{\text{DSS}} \) Variation with Temperature.

FIGURE 2-8: Transfer Characteristics.

FIGURE 2-9: Capacitance vs. Drain-to-Source Voltage.

FIGURE 2-10: On-Resistance vs. Drain Current.

FIGURE 2-11: \( V_{\text{GS(th)}} \) and \( R_{\text{DS}} \) Variation with Temperature.

FIGURE 2-12: Gate Drive Dynamic Characteristics.
3.0 PIN DESCRIPTION

The details on the pins of TN2130 are listed in Table 3-1. Refer to Package Type for the location of pins.

TABLE 3-1: PIN FUNCTION TABLE

<table>
<thead>
<tr>
<th>Pin Number</th>
<th>Pin Name</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td>Gate</td>
<td>Gate</td>
</tr>
<tr>
<td>2</td>
<td>Source</td>
<td>Source</td>
</tr>
<tr>
<td>3</td>
<td>Drain</td>
<td>Drain</td>
</tr>
</tbody>
</table>
4.0 FUNCTIONAL DESCRIPTION

Figure 4-1 illustrates the switching waveforms and test circuit for TN2130.

**FIGURE 4-1:** Switching Waveforms and Test Circuit.

<table>
<thead>
<tr>
<th>TABLE 4-1: PRODUCT SUMMARY</th>
<th></th>
<th></th>
<th></th>
</tr>
</thead>
<tbody>
<tr>
<td>( \text{BV}<em>{\text{DSS}} / \text{BV}</em>{\text{DGS}} ) (V)</td>
<td>( R_{\text{DS(ON)}} ) (Maximum) (Ω)</td>
<td>( V_{\text{GS(th)}} ) (Maximum) (V)</td>
<td></td>
</tr>
<tr>
<td>300</td>
<td>25</td>
<td>2.4</td>
<td></td>
</tr>
</tbody>
</table>
5.0 PACKAGING INFORMATION

5.1 Package Marking Information

Legend:

- **XX...X**: Product Code or Customer-specific information
- **Y**: Year code (last digit of calendar year)
- **YY**: Year code (last 2 digits of calendar year)
- **WW**: Week code (week of January 1 is week ‘01’)
- **NNN**: Alphanumeric traceability code
- **(e³)**: Pb-free JEDEC® designator for Matte Tin (Sn)
- *****: This package is Pb-free. The Pb-free JEDEC designator (e³) can be found on the outer packaging for this package.

Note: In the event the full Microchip part number cannot be marked on one line, it will be carried over to the next line, thus limiting the number of available characters for product code or customer-specific information. Package may or may not include the corporate logo.
3-Lead TO-236AB (SOT-23) Package Outline (K1/T)
2.90x1.30mm body, 1.12mm height (max), 1.90mm pitch

Note: For the most current package drawings, see the Microchip Packaging Specification at www.microchip.com/packaging.
APPENDIX A: REVISION HISTORY

Revision A (April 2019)

• Converted Supertex Doc# DSFP-TN2130 to Microchip DS20005944A
• Changed the package marking format
• Made minor text changes throughout the document

Revision B (June 2020)

• Added automotive specifications to the Electrical Characteristics section
• Added automotive specifications to the Product Information System section
• Made minor text changes throughout the document
**PRODUCT IDENTIFICATION SYSTEM**

To order or obtain information, e.g., on pricing or delivery, contact your local Microchip representative or sales office.

<table>
<thead>
<tr>
<th>PART NO.</th>
<th>Device</th>
<th>Package Options</th>
<th>Environmental</th>
<th>Media Type</th>
<th>Option</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>TN2130 = N-Channel Enhancement-Mode Vertical DMOS FET</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>K1 = 3-lead SOT-23</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>G = Lead (Pb)-free/RoHS-compliant Package</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>(blank) = 3000/Reel for a K1 Package</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>VAO = Automotive Grade</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

**Example:**

a) TN2130K1-G: N-Channel Enhancement-Mode, Vertical DMOS FET, 3-lead SOT-23 package, 3000/Reel

b) TN2130K1-G-VAO: N-Channel Enhancement-Mode, Vertical DMOS FET, Automotive Grade, 3-lead SOT-23 package, 3000/Reel
Note the following details of the code protection feature on Microchip devices:

- Microchip products meet the specification contained in their particular Microchip Data Sheet.
- Microchip believes that its family of products is one of the most secure families of its kind on the market today, when used in the intended manner and under normal conditions.
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